

<b>Notice of References Cited</b>	Application/Control No. 10/551,841		Applicant(s)/Patent Under Reexamination NUN ET AL.	
	Examiner FRANK I. CHOI		Art Unit 1616	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0016433	02-2002	Keller et al.	528/10
*	B	US-2004/0081818	04-2004	Baumann et al.	428/323
*	C	US-7,066,998	06-2006	Rohrbaugh et al.	106/286.5
*	D	US-6,955,834	10-2005	Rohrbaugh et al.	427/180
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 0119932 A2	03-2001	WIPO	GROS G	-----
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Patankar, Mimicking the lotus effect: Influence of double roughness structures and slender pillars, Langmuir (2004), Vol. 20, No. 19, pp. 8209-8213.
	V	Nun et al., Lotus-Effect-Surfaces, Macromol. Symp. (2002), Vol. 187, pp. 677-682.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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